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Page(s): 38 -41

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Page(s): 257 -260 vol.2

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Page(s): 917 -922

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Page(s): 793 -801

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Page(s): 167 -172 vol.2

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Page(s): 7/1 -7/6

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Page(s): 218 -225

[\[Abstract\]](#) [\[PDF Full-Text \(484 KB\)\]](#) **IEEE CNF**

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Page(s): 2 -7

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Page(s): 1457 -1459

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Page(s): 700 -716

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